Panasonic INDUSTRY

PhotoMOS



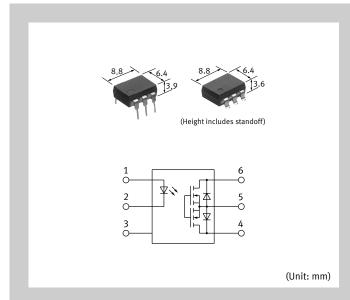






HE HE 1 Form A

DIP6-pin type with low on-resistance and reinforced insulation



FEATURES

- Wide variation of 40V, 60V, 100V, 200V, 250V, 400V, 600V, 1,000V and 1,500V load voltage
- ●Low on-resistance of Typ. 0.6Ω (AQV251)
- Reinforced insulation type of 5,000Vrms I/O isolation available

TYPICAL APPLICATIONS

- Measuring instruments
- Data communication equipment
- Telephone equipment
- Automatic meter reading device

Note: Please contact our sales representative for automotive applications of PhotoMOS.

TYPES

		Output	rating*1		Р	art No.		Packing quantity		
Category	I/O isolation voltage	Load	Load	Through hole terminal	S	Surface mount term	ninal	Tube	Tape and reel	
	voltage	voltage	current	Tube packing style	Tube packing style	Tape and reel packing style X*2	Tape and reel packing style Z*2	Tube		
		40 V	500 mA	AQV251	AQV251A	AQV251AX	AQV251AZ	1-tube: 50 pcs. Outer carton: 500 pcs.		
		60 V	400 mA	AQV252	AQV252A	AQV252AX	AQV252AZ		1-reel: 1,000 pcs. Outer carton: 1,000 pcs.	
		100 V	350 mA	AQV255	AQV255A	AQV255AX	AQV255AZ			
		200 V	250 mA	AQV257	AQV257A	AQV257AX	AQV257AZ			
10/00		250 V	200 mA	AQV253	AQV253A	AQV253AX	AQV253AZ			
AC/DC dual use		400 V	150 mA	AQV254	AQV254A	AQV254AX	AQV254AZ			
addi doc		1,000 V	30 mA	AQV259	AQV259A	AQV259AX	AQV259AZ	outer duriting door pos.		
		1,500 V	20 mA	AQV258	AQV258A	AQV258AX	AQV258AZ			
		250 V	200 mA	AQV253H	AQV253HA	AQV253HAX	AQV253HAZ			
	5,000 Vrms (Reinforced)	400 V	150 mA	AQV254H	AQV254HA	AQV254HAX	AQV254HAZ			
	(ixeiiiioiceu)	600 V	130 mA	AQV256H	AQV256HA	AQV256HAX	AQV256HAZ			

Note: The surface mount terminal shape indicator "A" and the packing style indicator "X" or "Z" are not marked on the device. (Ex. the label for product number AQV251AX is AQV251.)

^{*1.}Indicate the peak AC and DC values.

^{*2.} Tape and reel packing style X: picked from the 1/2/3-pin side, tape and reel packing style Z: picked from the 4/5/6-pin side.

RATING

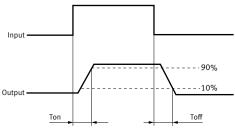
■ Absolute maximum ratings (Ambient temperature: 25°C)

	Item	Symbol	Type of connection	AQV251 (A)	AQV252 (A)	AQV255 (A)	AQV257 (A)	AQV253 (A)	AQV254 (A)	AQV259 (A)	AQV258 (A)	AQV253H (A)	AQV254H (A)	AQV256H (A)	Remarks
	LED forward current	lF	-						50 mA	٨					
Input	LED reverse voltage	VR	-		5 V										
Ē	Peak forward current	I _{FP}	-		1 A									f = 100 Hz, Duty Ratio = 0.1%	
	Power dissipation	Pin	-		75 mW										
	Load voltage (peak AC)	V∟	-	40 V	60 V	100 V	200 V	250 V	400 V	1,000 V	1,500 V	250 V	400 V	600 V	
	Continuous load current		А	0.5 A	0.4 A	0.35 A	0.25 A	0.2 A	0.15 A	0.03 A	0.02 A	0.2 A	0.15 A	0.13 A	A connection: Peak AC, DC
Ħ		l IL	В	0.7 A	0.6 A	0.45 A	0.35 A	0.3 A	0.18 A	0.04 A	0.025 A	0.3 A	0.18 A	0.14 A	B, C
Output			С	1.0 A	0.8 A	0.70 A	0.5 A	0.4 A	0.25 A	0.05 A	0.04 A	0.4 A	0.25 A	0.16 A	connection: DC
O	Peak load current	I _{peak}	-	1.8 A	1.5 A	1.0 A	0.75 A	0.6 A	0.5 A	0.09 A	0.06 A	0.6 A	0.5 A	0.4 A	A connection: 100 ms (1 shot), V _L = DC
	Power dissipation	Pout	-						360 m\	V					
	l power ipation	Р⊤	-						410 m\	V					
I/O	solation voltage	Viso	-				1,500	Vrms				5	5,000 Vrm	s	
Ambient temperature (Operating)		Торг	-					_	-40 to +8	5°C					(Avoid icing and condensation)
Ambient temperature (Storage)			-				_	_	40 to +10	00°C					

■ Electrical characteristics (Ambient temperature: 25°C)

	Item		Symbol	Type of connection	AQV251 (A)	AQV252 (A)	AQV255 (A)	AQV257 (A)	AQV253 (A)	AQV254 (A)	AQV259 (A)	AQV258 (A)	AQV253H (A)	AQV254H (A)	AQV256H (A)	Condition
	LED operate	Typical	l _{Fon}	_		0.9 mA 1.4 mA								I₁ = Max.		
	current	Maximum	1,011							3.0 m						
Input	LED turn off	Minimum	l _{Foff}	_						0.4 m	Α					I₁ = Max.
드	current	Typical	1,011					0.8						1.3 mA		
	LED dropout	Typical	VF	_				1	.25 V (1	.14 V a	t I₅ = 5 ı	mA)				I₅ = 50 mA
	voltage	Maximum	•				,			1.5 V		,	Y			00 113 (
		Typical	R _{on}	A	0.6 Ω	0.74 Ω	1.8 Ω	2.6 Ω	5.5 Ω	12.4 Ω	85 Ω	345 Ω	5.5 Ω	12.4 Ω	20 Ω	$I_F = 5 \text{ mA}$ $I_L = \text{Max}$.
	On resistance Typic Maxim Typic	Maximum	Non	A	1 Ω	1.4 Ω	2.5 Ω	4 Ω	8 Ω	16 Ω	200 Ω	500 Ω	8 Ω	16 Ω	30 Ω	∃ l∟ = Max. Within 1 s
		Typical	_	-	0.3 Ω	0.37 Ω	0.9 Ω	1.4 Ω	2.7 Ω	6.2 Ω	60 Ω	345 Ω	2.7 Ω	6.2 Ω	15 Ω	I _F = 5 mA
Output		Maximum	Ron	В	0.5 Ω	0.7 Ω	1.25 Ω	2 Ω	4 Ω	8 Ω	100 Ω	500 Ω	4 Ω	8 Ω	20 Ω	I∟= Max. Within 1 s
Q		Typical	_		0.15 Ω	0.18 Ω	0.45 Ω	0.7 Ω	1.4 Ω	3.1 Ω	30 Ω	160 Ω	1.4 Ω	3.1 Ω	7.5 Ω	I _F = 5 mA
		Maximum	Ron	С	0.25 Ω	0.35 Ω	0.63 Ω	1 Ω	2 Ω	4 Ω	50 Ω	250 Ω	2 Ω	4 Ω	10 Ω	l∟= Max. Within 1 s
	Off state leakage current	Maximum	I _{Leak}	-			1	AL			10	10 μΑ 1 μΑ				$I_F = 0 \text{ mA}$ V _L = Max.
	Turn on time*	Typical	Ton		1.7 ms	1.4 ms	0.9 ms	1.5 ms	0.8	ms	0.6 ms	0.35 ms	2.4 ms	1.8 ms	1.2 ms	I _F = 5 mA
tics	rum on ume	Maximum	Ion	-	3 ו	ms	2 ms	3 ms	2 r	ns	1 ו	ms	4 ms	3 r	ns	I∟ = Max.
teris	Turn off time*	Typical	Toff	_	0.07	ms ms	0.09 ms	0.1 ms	0.06 ms	0.05 ms	0.04	l ms	0.06 ms	0.05 ms	0.06 ms	I _F = 5 mA
ract	Turri on time	Maximum	Ion	-						0.2 m	s					I∟= Max.
cha	I/O	Typical	Ciso							1.3 pF	=					f = 1 MHz
fer	capacitance	Maximum	Oiso	-		3 pF								V _B = 0 V		
Transfer characteristics	Initial I/O isolation resistance	Minimum	Riso	-		1,000 ΜΩ					500 V DC					

*Turn on/Turn off time



■ Recommended operating conditions (Ambient temperature: 25°C)

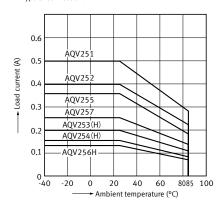
Please use under recommended operating conditions to obtain expected characteristics.

Item Symbol Min. Max. Unit			Item	Symbol	Min.	Max.	Unit				
L	ED current	I _F	5	30	mA	L	ED current	l _F	5	30	mA
AQV251 (A)	Load voltage (Peak AC)	V _L	ı	32	V	AQV259 (A)	Load voltage (Peak AC)	V _L	-	800	V
AQV251 (A)	Continuous load current (A connection)	I _L	ı	0.5	Α	AQV259 (A)	Continuous load current (A connection)	I _L	-	0.03	А
۸۵۷/252 (۸)	V252 (A) Load voltage (Peak AC) - 48 V AQV258 (A) Load voltage (Peak AC)	VL	-	1200	V						
AQV202 (A)	Continuous load current (A connection)	IL	-	0.4	Α	AQV236 (A)	Continuous load current (A connection)	I _L	-	0.02	Α
AQV255 (A)	Load voltage (Peak AC)	V _L - 80 V Load voltage (Peak AC)	V _L	-	200	V					
AQV255 (A)	Continuous load current (A connection)	IL	ı	0.35	Α	AQV255H (A)	Continuous load current (A connection)	I _L	-	0.2	А
AQV257 (A)	Load voltage (Peak AC)	V _L	-	160	V	AQV254H (A)	Load voltage (Peak AC)	V _L	-	320	V
AQV237 (A)	Continuous load current (A connection)	IL	ı	0.25	Α	AQV254H (A)	Continuous load current (A connection)	I _L	-	0.15	Α
AQV253 (A)	Load voltage (Peak AC)	VL	-	200	V	AQV256H (A)	Load voltage (Peak AC)	V∟	-	480	V
AQV200 (A)	Continuous load current (A connection)	l.	-	0.2	Α	AQV230H (A)	Continuous load current (A connection)	l.	-	0.13	Α
AQV254 (A)	Load voltage (Peak AC)	VL	-	320	V						
AQV204 (A)	Continuous load current (A connection)	l.	-	0.15	Α						

REFERENCE DATA

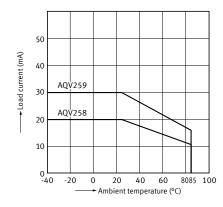
1-1.Load current vs. ambient temperature characteristics

Allowable ambient temperature: $-40 \text{ to } +85^{\circ}\text{C}$ Type of connection: A



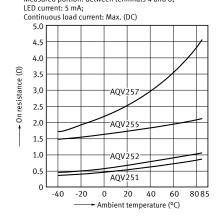
1-2.Load current vs. ambient temperature characteristics

Allowable ambient temperature: $-40 \text{ to } +85^{\circ}\text{C}$ Type of connection: A



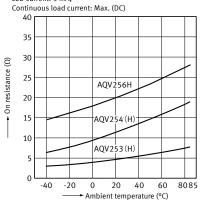
2-1.On resistance vs. ambient temperature characteristics

Measured portion: between terminals 4 and 6;



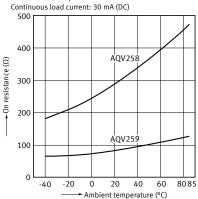
2-2.On resistance vs. ambient temperature characteristics

Measured portion: between terminals 4 and 6; LED current: 5 mA:



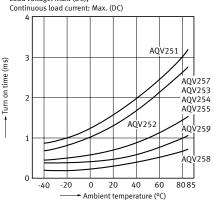
2-3.On resistance vs. ambient temperature 3-1.Turn on time vs. ambient temperature characteristics

Measured portion: between terminals 4 and 6; LED current: 5 mA:



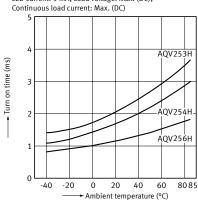
characteristics

LED current: 5 mA; Load voltage: Max. (DC):



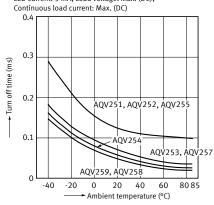
3-2. Turn on time vs. ambient temperature characteristics

LED current: 5 mA; Load voltage: Max. (DC);



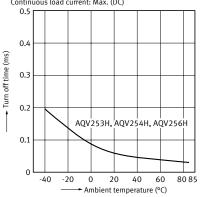
4-1. Turn off time vs. ambient temperature characteristics

LED current: 5 mA; Load voltage: Max. (DC);



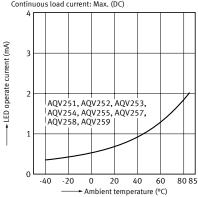
4-2. Turn off time vs. ambient temperature characteristics

LED current: 5 mA: Load voltage: Max. (DC): Continuous load current: Max. (DC)



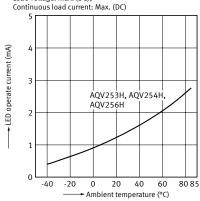
5-1.LED operate current vs. ambient temperature characteristics

Load voltage: Max. (DC); Continuous load current: Max. (DC)



5-2.LED operate current vs. ambient temperature characteristics

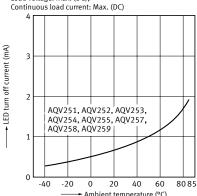
Load voltage: Max. (DC);



- 4 ---

6-1.LED turn off current vs. ambient temperature characteristics

Load voltage: Max. (DC);



6-2.LED turn off current vs. ambient temperature characteristics

Load voltage: Max. (DC);
Continuous load current: Max. (DC)

5

4

4

AQV253H, AQV254H, AQV256H

1

-40

-20

20

40

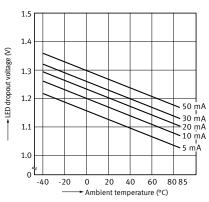
60

80

85

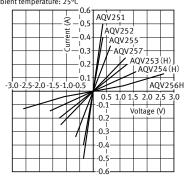
7.LED dropout voltage vs. ambient temperature characteristics

LED current: 5 to 50 mA



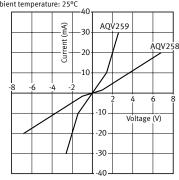
8-1.Current vs. voltage characteristics of output at MOS portion

Measured portion: between terminals 4 and 6; Ambient temperature: 25°C



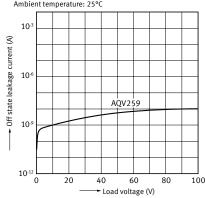
8-2.Current vs. voltage characteristics of output at MOS portion

Measured portion: between terminals 4 and 6; Ambient temperature: 25°C



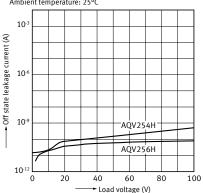
9-1.Off state leakage current vs. load voltage characteristics

Measured portion: between terminals 4 and 6; Ambient temperature: 25°C



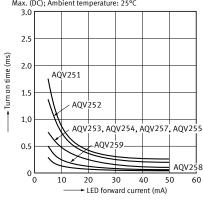
9-2.Off state leakage current vs. load voltage characteristics

Measured portion: between terminals 4 and 6; Ambient temperature: 25°C



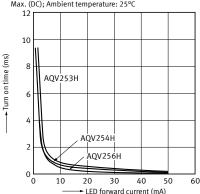
10-1.Turn on time vs. LED forward current characteristics

Measured portion: between terminals 4 and 6; Load voltage: Max. (DC); Continuous load current: Max. (DC); Ambient temperature: 25°C



10-2.Turn on time vs. LED forward current characteristics

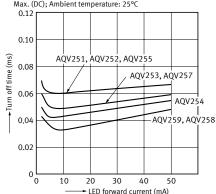
Measured portion: between terminals 4 and 6; Load voltage: Max. (DC); Continuous load current: Max. (DC); Ambient temperature: 25°C



- 5 --

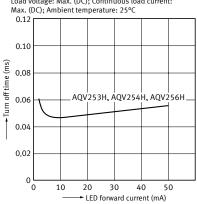
11-1.Turn off time vs. LED forward current characteristics

Measured portion: between terminals 4 and 6; Load voltage: Max. (DC); Continuous load current: Max. (DC); Ambient temperature: 25°C



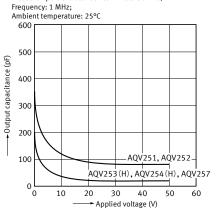
11-2.Turn off time vs. LED forward current characteristics

Measured portion: between terminals 4 and 6; Load voltage: Max. (DC); Continuous load current: Max. (DC); Ambient temperature: 25°C

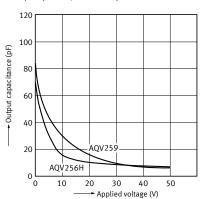


12-1. Output capacitance vs. applied voltage 12-2. Output capacitance vs. applied voltage characteristics characteristics

Measured portion: between terminals 4 and 6;



Measured portion: between terminals 4 and 6; Frequency: 1 MHz; Ambient temperature: 25°C



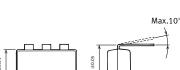
DIMENSIONS

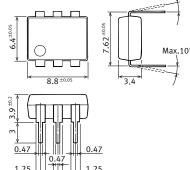
CAD The CAD data of the products with a "CAD" mark can be downloaded from our Website.

Unit: mm

CAD

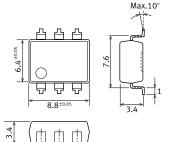
Through hole terminal type External dimensions



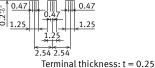


Terminal thickness: t = 0.25General tolerance: ±0.1

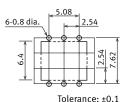
Surface mount terminal type External dimensions



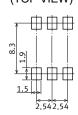
General tolerance: ±0.1



PC board pattern (BOTTOM VIEW)



Recommended mounting pad (TOP VIEW)



Tolerance: ±0.1

SCHEMATIC AND WIRING DIAGRAMS

2.54 2.54

Schematic	Output configuration	Load type	Connection	Wiring diagram
	1 Form A	AC/DC	А	E1 T F 2
10-4-6		DC	В	E1 — F 2
20				5 4 Load 1 Load 1 Load 1 Load 1 Load 1 Load 1 Load 1 Load 1 Load
				Can be also connected as 2 Form A type. (However, the sum of the continuous load current should not exceed the absolute maximum rating.)
		DC	С	E1 F 2 S F IL VL (DC)

^{*}Terminal 3 cannot be used, since it is in the internal circuit of the device.

SAFETY STANDARDS

		U	L (Recognized)	С	SA (Certified)	
Part I	No.	File No. (Standard No.)	Contact rating	File No. (Standard No.)	Contact rating	Remarks
	AQV251 (A)		0.5A 40V AC (peak) A connection 0.5A 40V DC A connection 0.7A 40V DC B connection 1.0A 40V DC C connection			
	AQV252 (A)		0.4A 60V AC (peak) A connection 0.4A 60V DC A connection 0.6A 60V DC B connection 0.8A 60V DC C connection			
	AQV255 (A)		0.35A 100V AC (peak) A connection 0.35A 100V DC A connection 0.45A 100V DC B connection 0.70A 100V DC C connection			
	AQV257(A)		0.25A 200V AC (peak) A connection 0.25A 200V DC A connection 0.35A 200V DC B connection 0.5A 200V DC C connection			
	AQV253 (A)		0.2A 250V AC (peak) A connection 0.2A 250V DC A connection 0.3A 250V DC B connection 0.4A 250V DC C connection			
AC/DC dual use	AQV253H (A)	E191218 (UL1577)	0.2A 250V AC (peak) A connection 0.2A 250V DC A connection 0.3A 250V DC B connection 0.4A 250V DC C connection	(Ce	(Certified by C-UL)	BSI approved (EN62368-1) No.VC649393
	AQV254 (A)		0.15A 400V AC (peak) A connection 0.15A 400V DC A connection 0.18A 400V DC B connection 0.25A 400V DC C connection			
	AQV254H (A)		0.15A 400V AC (peak) A connection 0.15A 400V DC A connection 0.18A 400V DC B connection 0.25A 400V DC C connection			BSI approved (EN62368-1) No.VC649393
	AQV256H (A)		0.13A 400V AC (peak) A connection 0.13A 400V DC A connection 0.14A 400V DC B connection 0.16A 400V DC C connection			VDE approved (Nr. 40032097)
	AQV259 (A)		0.03A 400V AC (peak) A connection 0.03A 600V DC A connection 0.04A 600V DC B connection 0.05A 600V DC C connection			
	AQV258 (A)		0.02A 400V AC (peak) A connection 0.02A 600V DC A connection 0.025A 600V DC B connection 0.04A 600V DC C connection			VDE approved (Nr. 40032097)

Note: For the latest information on compliance with safety standards, please refer to our website.

Please refer to "the latest product specifications" when designing your product.

•Requests to customers:

https://industrial.panasonic.com/ac/e/salespolicies/

PhotoMOS® Cautions for Use

ASAFETY WARNINGS

- Do not use the product under conditions that exceed the range of its specifications. It may cause overheating, smoke, or fire.
- Do not touch the recharging unit while the power is on. There is a danger of electrical shock. Be sure to turn off the power when performing mounting, maintenance, or repair operations on the device (including connecting parts such as the terminal board and socket).
- Check the wiring diagrams in the catalog and be sure to connect the terminals correctly. If the device is energized with short circuit or any wrong connection, it may cause unexpected malfunction, abnormal heat or fire.

PhotoMOS® Cautions for Use

■ Derating design

Derating is a significant factor for reliable design and product life. Even if the conditions of use (temperature, current, voltage, etc.) of the product are within the absolute maximum ratings, reliability may be lowered remarkably when continuously used in high load conditions (high temperature, high humidity, high current, high voltage, etc.) Therefore, please derate sufficiently below the absolute maximum ratings and evaluate the device in the actual condition.

Moreover, regardless of the application, if malfunctioning can be expected to pose high risk to human life or to property, or if products are used in equipment otherwise requiring high operational safety, in addition to designing double circuits, that is, incorporating features such as a protection circuit or a redundant circuit, safety testing should also be carried out.

■ Applying stress that exceeds the absolute maximum rating

If the voltage or current value for any of the terminals exceeds the absolute maximum rating, internal elements will deteriorate because of the overvoltage or overcurrent. In extreme cases, wiring may melt, or silicon P/N junctions may be destroyed.

Therefore, the circuit should be designed in such a way that the load never exceed the absolute maximum ratings, even momentarily.

■Input voltage (for Voltage-sensitive type)

For rising and dropping ratio of input voltage(dv/dt), maintain Min. 100mV/ms.

■ Oscillation circuit and control circuit (for TSON)

The oscillation circuit and control circuit of product may be destroyed by external noise, surge, static electricity and so on.

For noise effect to peripheral circuits when oscillation circuit operates, please implement safety measures on the system before use by verifying operation under the actual design.

■ Deterioration and destruction caused by discharge of static electricity (for TSON/RF C×R3/RF C×R5/RF C×R10)

This phenomenon is generally called static electricity destruction, and occurs when static electricity generated by various factors is discharged while the PhotoMOS® terminals are in contact, producing internal destruction of the element.

To prevent problems from static electricity, the following precautions and measures should be taken when using your device.

- 1) Employees handling PhotoMOS® should wear anti-static clothing and should be grounded through protective resistance of $500k\Omega$ to $1M\Omega$.
- A conductive metal sheet should be placed over the worktable. Measuring instruments and jigs should be grounded.
- When using soldering irons, either use irons with low leakage current, or ground the tip of the soldering iron. (Use of low-voltage soldering irons is also recommended.)
- 4) Devices and equipment used in assembly should also be grounded.

- 5) When packing printed circuit boards and equipment, avoid using high-polymer materials such as foam styrene, plastic, and other materials which carry an electrostatic charge.
- 6) When storing or transporting PhotoMOS®, the environment should not be conducive to generating static electricity (for instance, the humidity should be between 45% and 60%), and PhotoMOS® should be protected using conductive packing materials.

■Unused terminals

The No. 3 terminal is used with the circuit inside the device. Therefore, do not connect it to the external circuitry with either connection method A, B or C. (1 Form A 6-pin type)

■Short across terminals

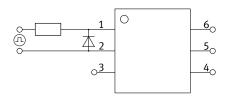
Do not short circuit between terminals when device is energized, since there is possibility of breaking of the internal IC.

■Surge voltages at the input

If reverse surge voltages are present at the input terminals, connect a diode in reverse parallel across the input terminals and keep the reverse voltages below the reverse breakdown voltage.

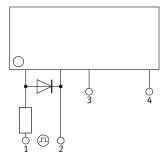
Typical circuits are below shown.

1) 6-pin



2) Power type

- 8 **—**



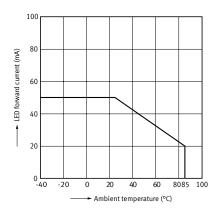
Recommended LED forward current or recommended input voltage

Design in accordance with the recommended operating conditions for each product.

Since these conditions are affected by the operating environment, ensure conformance with all relevant specifications.

■LED forward current vs. Ambient temperature characteristics

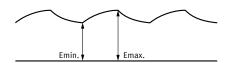
Please keep the LED forward current to within the range given below.



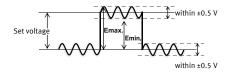
■ Ripple in the input power supply

If ripple is present in the input power supply, observe the following:

- For LED forward current at E_{min}, please maintain the value mentioned at "■Recommended LED forward current."
- 2) Please make sure the LED forward current for E_{max} . is no higher than 50 mA.
- 3) Please maintain the input voltage at least 4V for Emin. (GU, RF and Power voltage-sensitive type).
- 4) Please make sure the input voltage for E_{max} . is no higher than 6V (GU and RF voltage-sensitive type).
- Please make sure the input voltage for E_{max}. is no higher than 30V (Power voltage-sensitive type).

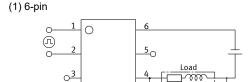


- 6) Please maintain the input voltage at least 3V for Emin. (for TSON)
- 7) Please make sure the input voltage for E_{max} . is no higher than 5.5V. (for TSON)
- 8) Please keep amplitude voltage of ripple within ±0.5V. (for TSON)

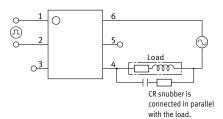


■Output spike voltages

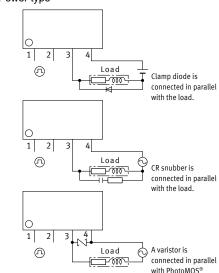
 If an inductive load generates spike voltages which exceed the absolute maximum rating, the spike voltage shall be limited. Representative circuit examples of AC/DC dual use type are shown below. There are the same with DC only type.



Clamp diode is connected in parallel with the load.

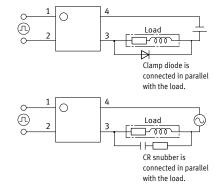


(2) Power type



(3) TSON

9 —



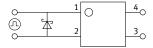
2) When Clamp diode or CR Snubber is used in the circuit, the spike voltages from the load are limited. But the longer wire may become the inductance and cause the spike voltage. Keep the wire as short as possible.

ASCTB65E 202002

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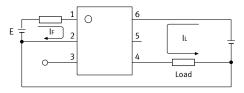
■ Reverse voltages at the input (for TSON)

If reverse voltages are present at the input terminals, for example, connect a schottky barrier diode in reverse parallel across the input terminals and keep the reverse voltages below the reverse breakdown voltage. Typical circuit is shown below.



■ Continual DC bias (AQV259 and AQV258)

If a continual DC bias will be applied between the input and output, the breakdown voltage of the switching element MOSFET on the output side may degrade. Therefore, be sure to test the product under actual conditions. Example of circuits that will cause degradation of breakdown voltage of MOSFET is given below.



■ Cleaning solvents compatibility

Cleaning the solder flux should use the immersion washing with an organic solvent. If you have to use ultrasonic cleaning, please adopt the following conditions and check that there are no problems in the

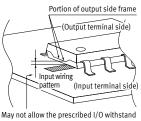
- Frequency: 27 to 29kHz
- Ultrasonic output: No greater than 0.25W/cm^{2*}
- · Cleaning time: 30s or less
- Cleanser used: Asahiklin AK-225
- · Others: Float PCB and the device in the cleaning solvent to prevent from contacting the ultrasonic vibrator
- * Applies to unit area ultrasonic output for ultrasonic baths

■ Notes for mounting

- 1) When different kinds of packages are mounted on PC boad, temperature rise at soldering lead is highly dependent on package size. Therefore, please set the lower temperature soldering condition than the conditions of item "Soldering", and confirm the temperature condition of actual usage before
- 2) When soldering condition exceeds our recommendation, the PhotoMOS® characteristics may be adversely affected. It may occur package crack or bonding wire breaking because of thermal expansion unconformity and resin strength reduction. Please contact our sales office about the propriety of the
- 3) Please confirm the heat stress by using actual board because it may be changed by board condition or manufacturing process condition.
- 4) Solder creepage, wettability, or soldering strength will be affected by the soldering condition or used soldering type. Please check them under the actual production condition in detail.
- 5) Please apply coating when the device returns to a room temperature.

■Input wiring pattern

1) With AQY* or AQW* series avoid installing the input (LED side) wiring pattern to the bottom side of the package if you require the specified I/O isolation voltage (Viso) after mounting the PC board. Since part of the frame on the output side is exposed, it may cause fluctuations in the I/O isolation voltage.

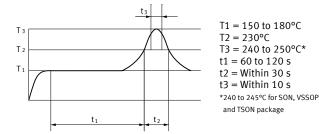


voltage (Viso) to be achieved

- * Excluding reinforced insulation products and SSOP, SON, and TSON packages
- 2) Exposed terminals are electrically connected to internal elements. Be aware that contact with external circuits may cause deterioration of insulation between input and output, leading to destruction of internal elements.
- 3) If installed in proximity to other device, take care to avoid short circuits between device, which may occur if exposed frames of adjacent device come too close.

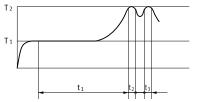
■ Soldering

- 1) Example of surface-mount terminal recommended conditions
 - (1) IR (Infrared reflow) soldering method In case of automatic soldering, following conditions should be observed. (recommended condition reflow: Max. 2 times, measurement point: soldering lead)



- (2) Other soldering methods Other soldering methods (VPS, hot-air, hot plate, laser heating, pulse heater, etc.) affect the PhotoMOS® characteristics differently, please evaluate the device under the actual usage.
- (3) Manual soldering method Temperature: 350 to 400°C, within 3s, electrical power 30 to 60W
- 2) Example of through hole terminal recommended conditions
 - (1) DWS soldering method

In case of automatic soldering, following conditions should be observed. (recommended condition number of times: Max. 1 time, measurement point: soldering lead *1)



 $T_1 = 120^{\circ}C$ $T_2 = Max. 260^{\circ}C$ $t_1 = within 60 s$ $t_2+t_3 = within 5 s$

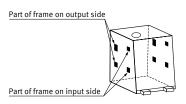
*1 Solder temperature: Max. 260°C

- (2) Other soldering method (recommended condition: 1 time) Preheating: Max. 120°C, within 120s, measurement point: soldering lead Soldering: Max. 260°C, within 10s, measurement area: soldering temperature
- (3) Manual soldering method Temperature: 350 to 400°C, within 3s, electrical power 30 to 60W

■ About the exposed terminals on the sides of the package (for VSSOP)

For VSSOP type, as shown in the following figure, part of the input and output frames are exposed on the sides of the package. Due to this, please be keep in mind the cautions listed below.

- Take care to avoid short circuits between exposed terminals, which may cause insulation deterioration between input and output, leading to destruction of internal elements.
- 2) Since the exposed terminals are connected electrically to the internal element, please refer to the item "■Deterioration and destruction caused by discharge of static electricity", and implement sufficient measures to control static electricity.
- 3) When installing the devices in the vicinity, please keep in mind that if the exposed frames of adjacent devices get too close, a short between devices may occur.



■Adjacent mounting

When several PhotoMOS® are mounted closely each other or heat-generating components are mounted close to the PhotoMOS®, the abnormal heating may occur. This abnormal heat may be caused by the internal element when energized or thermal interference between the devices. The degree of temperature rise depends on the mounting layout of the devices and usage condition, therefore please be sure to use PhotoMOS® with reduced load current after testing under the worst condition of the actual usage.

■ Transportation and storage

- Extreme vibration during transport may deform the lead or damage the PhotoMOS® characteristics. Please handle the outer and inner boxes with care.
- Inadequate storage condition may degrade soldering, appearance, and characteristics. The following storage conditions are recommended:

Temperature: 0 to 45°C
Humidity: Max. 70%RH

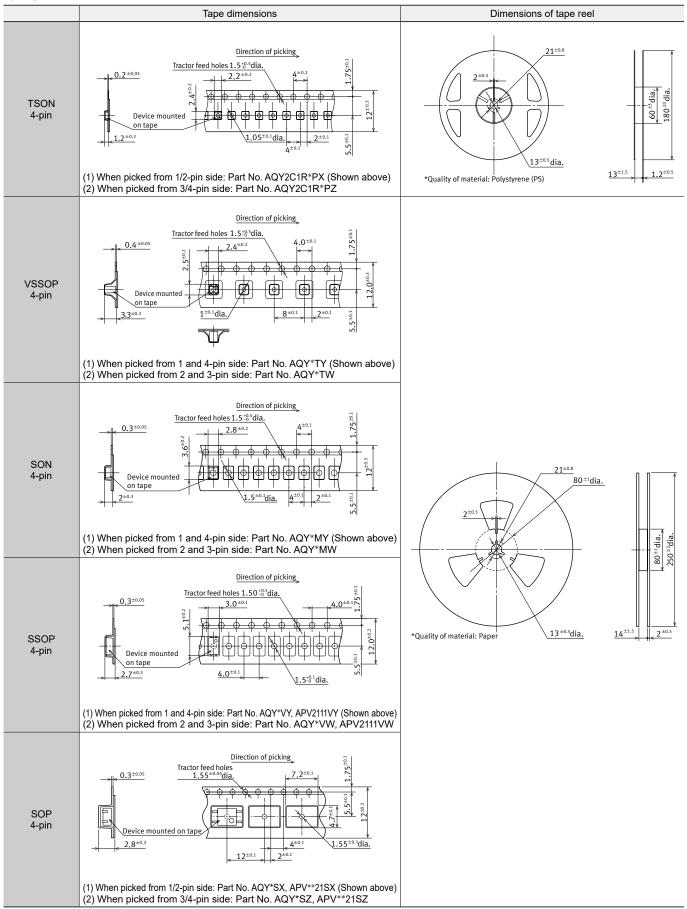
- Atmosphere: No harmful gasses such as sulfurous acid gas, minimal dust.
- 3) Storage before TSON, VSSOP, SON, SSOP, or SOP processing In case the heat stress of soldering is applied to the PhotoMOS® which absorbs moisture inside of its package, the evaporation of the moisture increases the pressure inside the package and it may cause the package blister or crack. This device is sensitive to moisture and it is packed in the sealed moisture-proof package. Please make sure the following condition after unsealing.
 - * Please use the device immediately after unsealing. (Within 30 days at 0 to 30°C and Max. 70%RH)
 - * If the device will be kept for a long time after unsealing, please store in the another moisture-proof package containing silica gel. (Please use within 90 days.)

■Water condensation

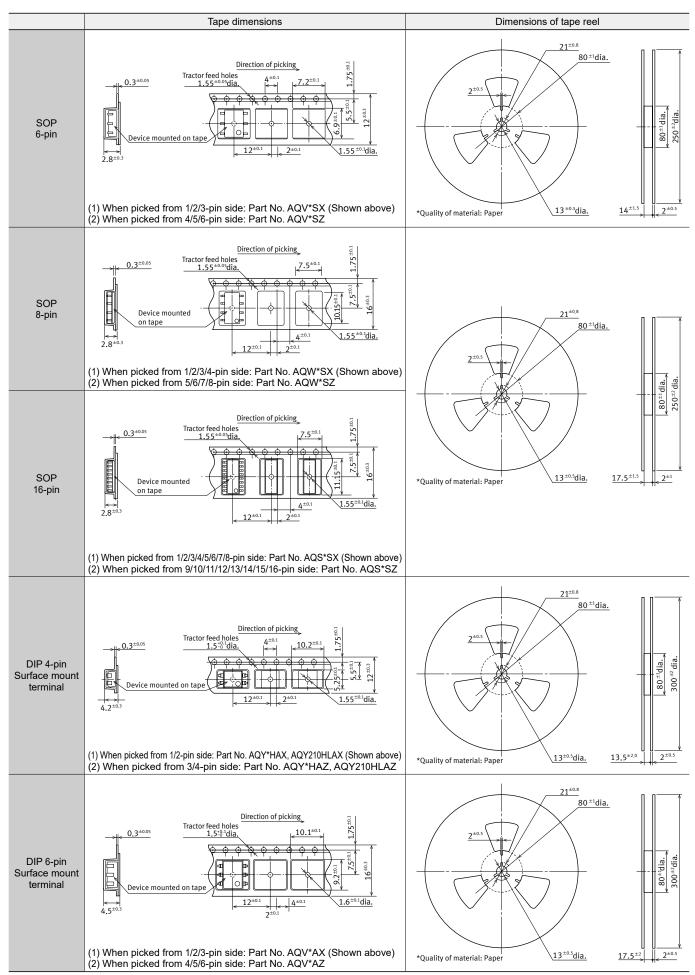
Water condensation occurs when the ambient temperature changes suddenly from a high temperature to low temperature at high humidity, or the device is suddenly transferred from a low ambient temperature to a high temperature and humidity. Condensation causes the failures such as insulation deterioration. Panasonic Corporation does not guarantee the failures caused by water condensation. The heat conduction by the equipment the PhotoMOS® is mounted may accelerate the water condensation. Please confirm that there is no condensation in the worst condition of the actual usage. (Special attention should be paid when high temperature heating parts are close to the PhotoMOS®.)

■ Packing format

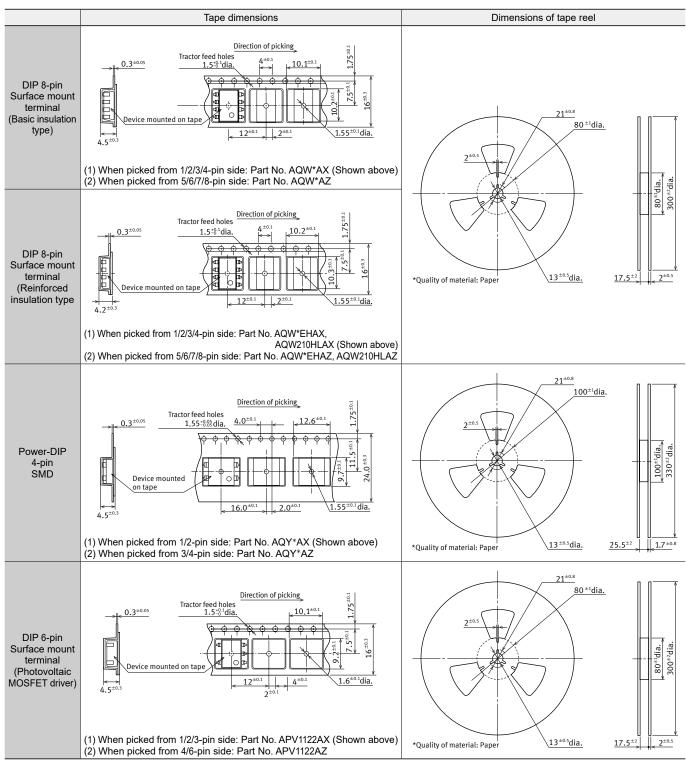
1) Tape and reel



Note: " * " indicates characters of number or alphabet.



Note: " * " indicates characters of number or alphabet.

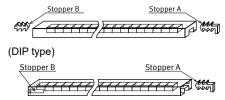


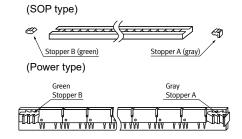
Note: " * " indicates characters of number or alphabet.

2) Tube

Devices are packaged in a tube so that 1-pin is on the stopper B side. Observe correct orientation when mounting them on PC boards.

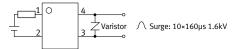
(PD type)





■ Current limit function (output current control)

 Current limit function aims to increase resistance to surges when the switch is turned on. Before using this function, connect the varistor to the output as shown in the figure below.



- * Set the varistor voltage to 150 V or less.
- 2) The current limit function capability can be lost if used longer than the specified time. Be sure to set the output loss to the Max. rate.

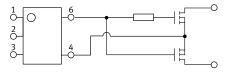
■ Short circuit protection circuit

The short circuit protection circuit is designed to protect circuits from excess current. Therefore, surge current may be detected as current overload in which case the output current will be cut and the off state maintained. For this reason, please include the inrush current in the load current and keep it below the maximum load current. Also, in order to maintain stability of internal IC operation, maintain an input current of at least 5 mA (Latch type), 10 mA (Non Latch type).

■ Photovoltaic MOSFET driver cautions for use

When two external MOSFETs are connected with a common source terminal, oscillation may occur when operation is restored. Therefore, please insert a 100 to 1,000 Ω resistor between the gate terminal of the first MOSFET and the gate terminal of the second MOSFET.

A typical example of this is given in the circuit below.



■Input LED current (for Standard type)

For rising and dropping ratio of input LED current (di/dt), maintain Min. 100 $\mu\text{A/s}.$

■ Input voltage (for Power voltage-sensitive type) For rising and dropping ratio of input voltage (dv/dt), maintain Min. 100 mV/s.

■Adjacent mounting (for Power type)

- When devices are mounted close together with the heatgenerated devices, ambient temperature may rise abnormally. Mounting layout and ventilation should be considered.
- 2) When many devices are mounted close together, load current should be reduced. (Refer to the data of "Load current in adjacent mounting vs. Ambient temperature characteristics.")

■ Recommended load voltage

As a guide in selecting PhotoMOS®, please refer to the following table.

1) Power photoMOS® (1 Form A)

		Absolute ma	ximum rating	Recommended	
		Load voltage	Load current	load voltage	
	AQZ102	60 V DC	4.0 A DC	5, 12, 24 V DC	
DC	AQZ105	100 V DC	2.6 A DC	48 V DC	
type	AQZ107	200 V DC	1.3 A DC	100 V DC	
	AQZ104	400 V DC	0.7 A DC	200 V DC	
	AQZ202	Peak AC, DC 60 V	Peak AC, DC 3.0 A	12 V AC 5, 12, 24 V DC	
AC/	AQZ205	Peak AC, DC 100 V	Peak AC, DC 2.0 A	24 V AC 48 V DC	
DC type	AQZ207	Peak AC, DC 200 V	Peak AC, DC 1.0 A	48 V AC 100 V DC	
	AQZ204	Peak AC, DC 400 V	Peak AC, DC 0.5 A	120 V AC 200 V DC	

2) Power photoMOS® (1 Form B)

			Absolute ma	Recommended	
			Load voltage	Load current	load voltage
	AC/ DC type	AQZ404	Peak AC, DC 400 V	Peak AC, DC 0.5 A	100 V AC 200 V DC

3) Power photoMOS® Voltage-sensitive type (1 Form A)

		Absolute ma	ximum rating	Recommended	
		Load voltage	Load current	load voltage	
	AQZ102D	60 V DC	3.6 A DC	5, 12, 24 V DC	
DC	AQZ105D	100 V DC	2.3 A DC	48 V DC	
type	AQZ107D	200 V DC	1.1 A DC	100 V DC	
	AQZ104D	400 V DC	0.6 A DC	200 V DC	
	AQZ202D	Peak AC, DC 60 V	Peak AC, DC 2.7 A	12 V AC 5, 12, 24 V DC	
AC/ DC		Peak AC, DC 100 V	Peak AC, DC 1.8 A	24 V AC 48 V DC	
type	AQZ207D	Peak AC, DC 200 V	Peak AC, DC 0.9 A	48 V AC 100 V DC	
	AQZ204D	Peak AC, DC 400 V	Peak AC, DC 0.45 A	120 V AC 200 V DC	

4) Power photoMOS® High Capacity type (1 Form A)

		Absolute ma	ximum rating	Recommended	
		Load voltage	Load current	load voltage	
DC	AQZ192	60 V DC	10 A DC	5, 12, 24 V DC	
type	AQZ197	200 V DC	5 A DC	100 V DC	
	AQZ202G	Peak AC, DC 60 V	Peak AC, DC 6 A	12 V AC 5, 12, 24 V DC	
AC/ DC	AQZ205G	Peak AC, DC 100 V	Peak AC, DC 4 A	24 V AC 48 V DC	
type	AQZ207G	Peak AC, DC 200 V	Peak AC, DC 2 A	48 V AC 100 V DC	
	AQZ206G2	Peak AC, DC 600 V	Peak AC, DC 1 A	120, 240 V AC 200, 400 V DC	

- 15 --

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